Design for Maintainability Model-Based Diagnostics of a NASA Satellite Power System



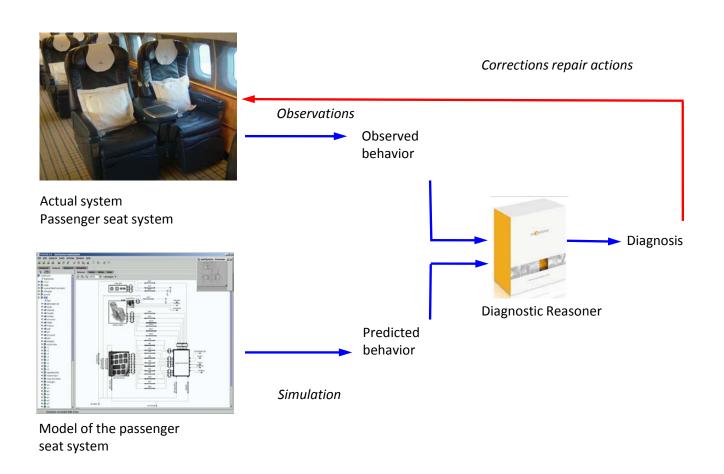
Peter Bunus, Olle Isaksson petbu@ida.liu.se



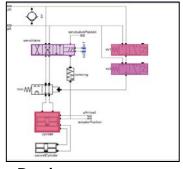
Definition of Diagnosis

As a subfield in <u>artificial intelligence</u>, **Diagnosis** is concerned with the development of algorithms and techniques that are able to determine whether the behavior of a system is correct. If the system is not functioning correctly, the algorithm should be able to determine, as accurately as possible, which part of the system is failing, and which kind of fault it is facing. The computation is based on *observations*, which provide information on the current behavior.

Model-Based Diagnosis Principles



The Diagnostic Problem



Design Structural Description

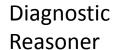
*V=i*R*Domain Knowledge

Component



Measurements/
Observations

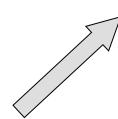




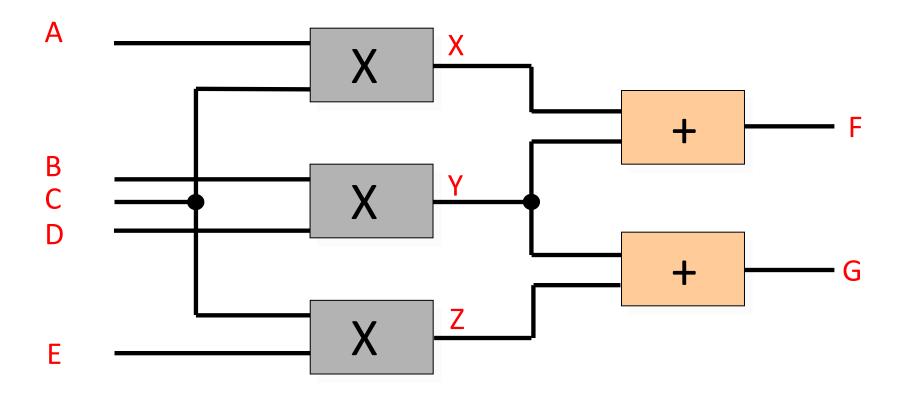


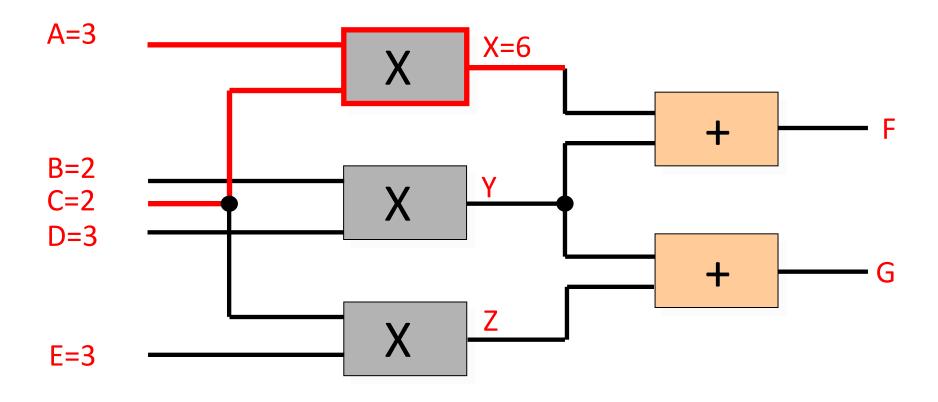
Diagnosis Repair Actions

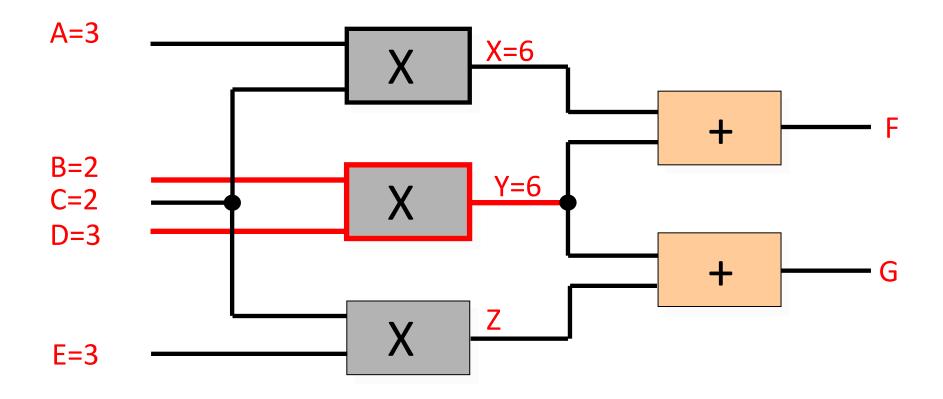
Replace servoValve

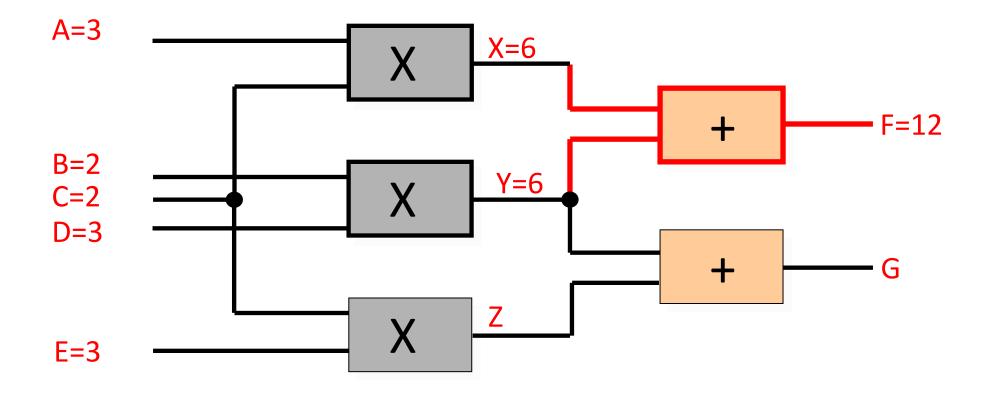


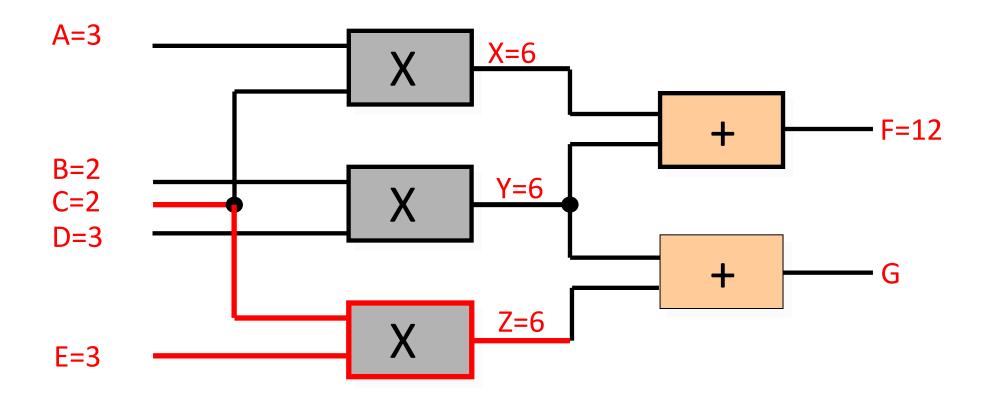
X=6V

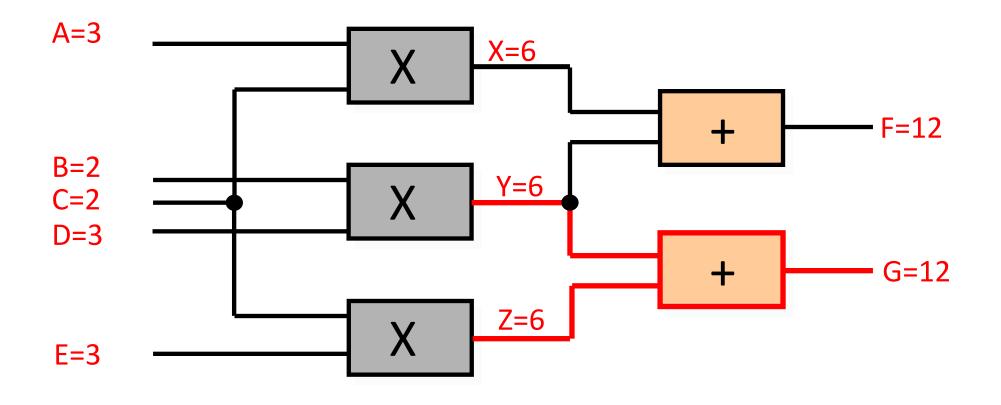




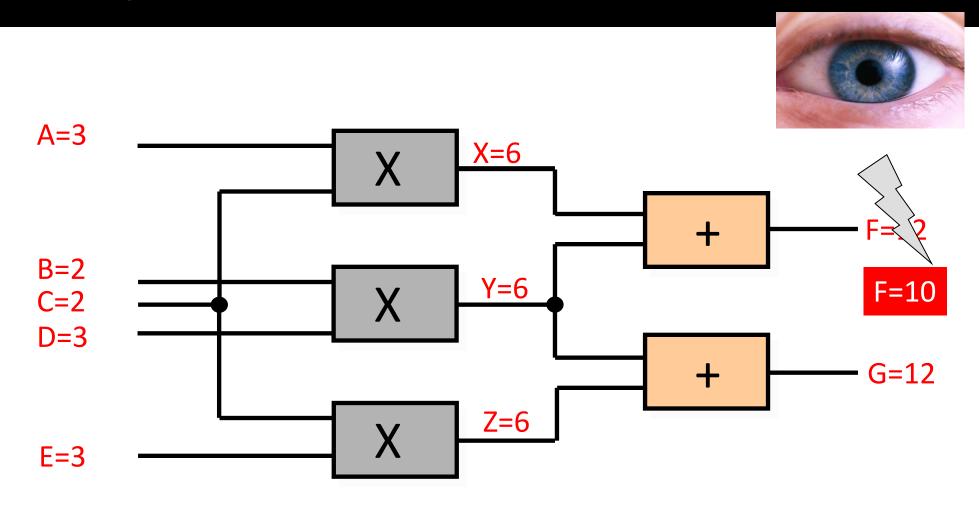




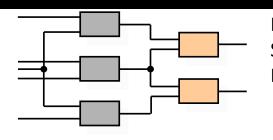




Adding Observations



The Diagnostics Problem



Design Structural Description

RODON

Diagnosis Repair Actions

Domain Knowledge Component

adder -> out=in1+in2

*mult -> out=int1*int2*



{A1}{M1}{A2M2}{M2M3}

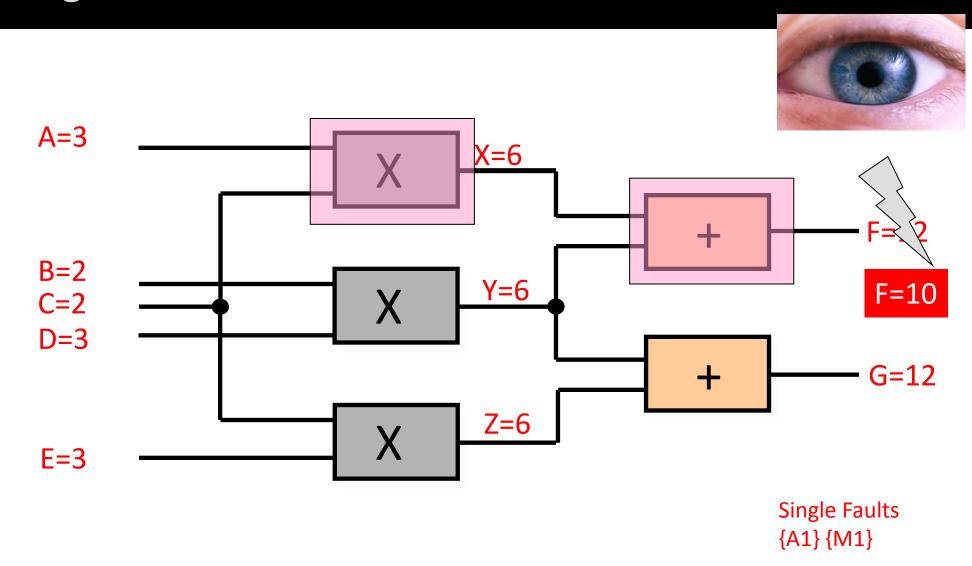


Observations

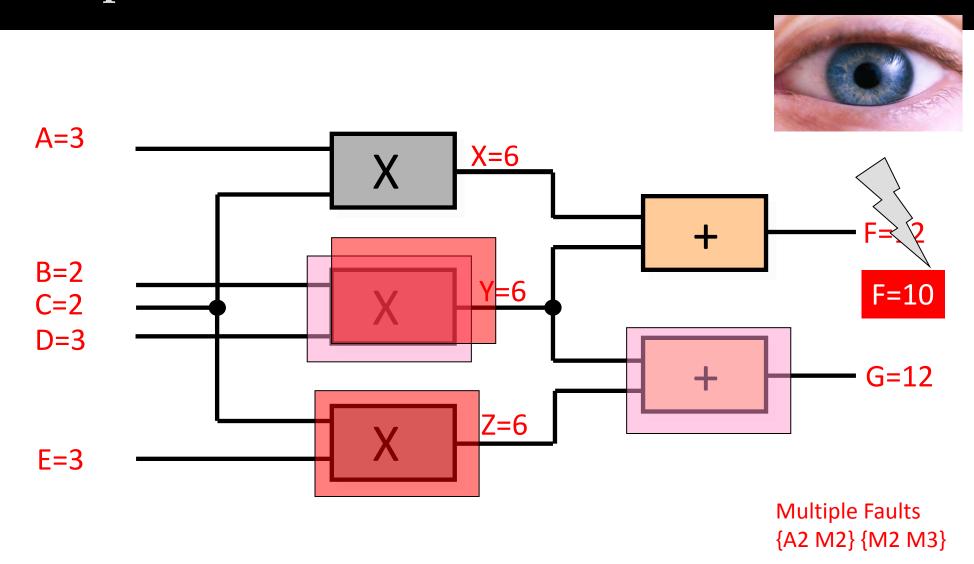
A=3; B=2; C=2; D=3; E=3;

F=10; *G*=12;

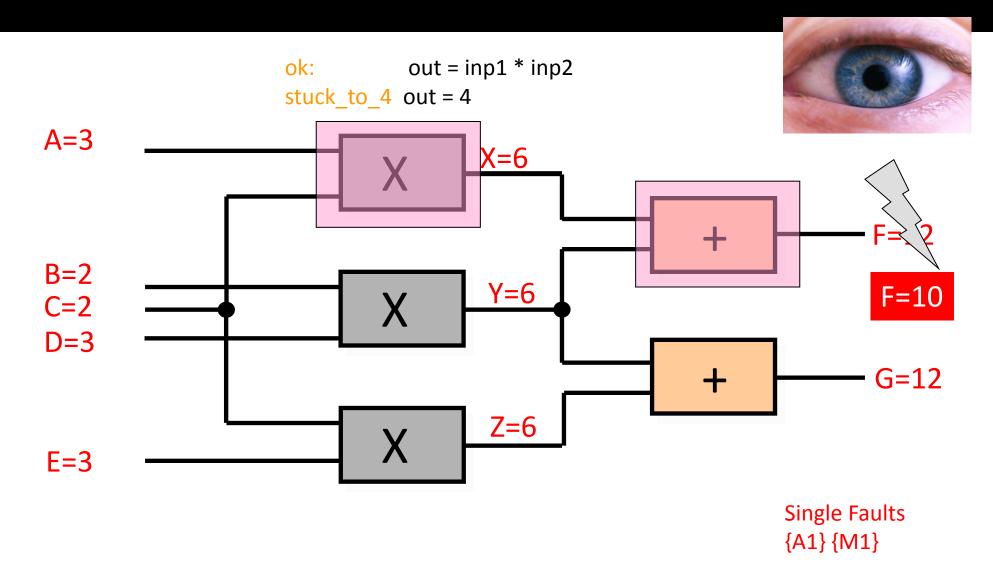
Single Faults



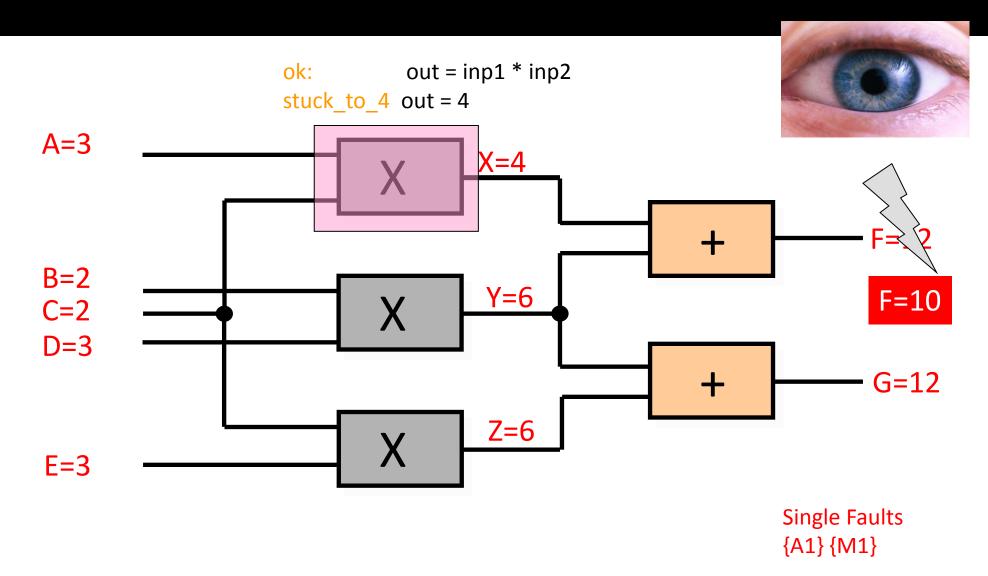
Multiple Faults



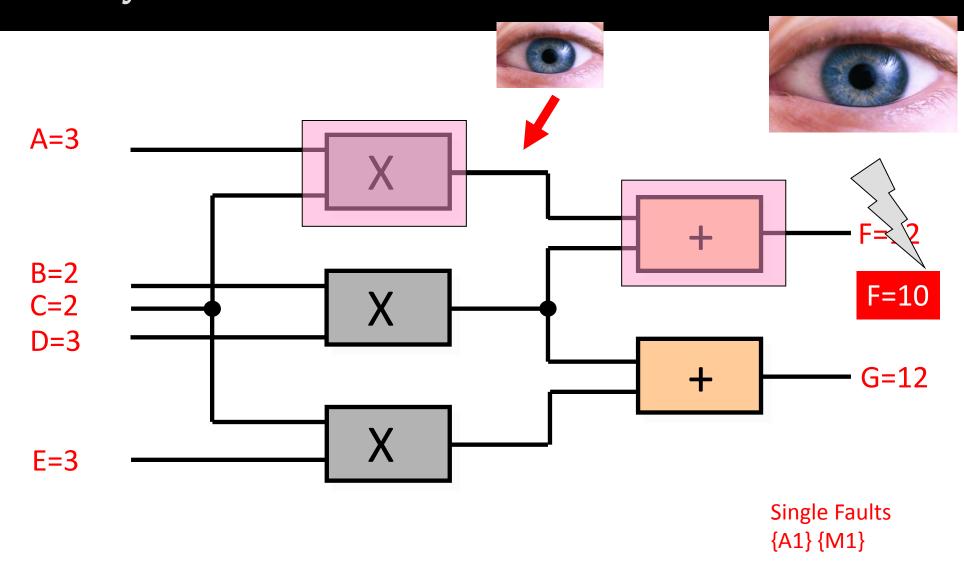
Failure Modes



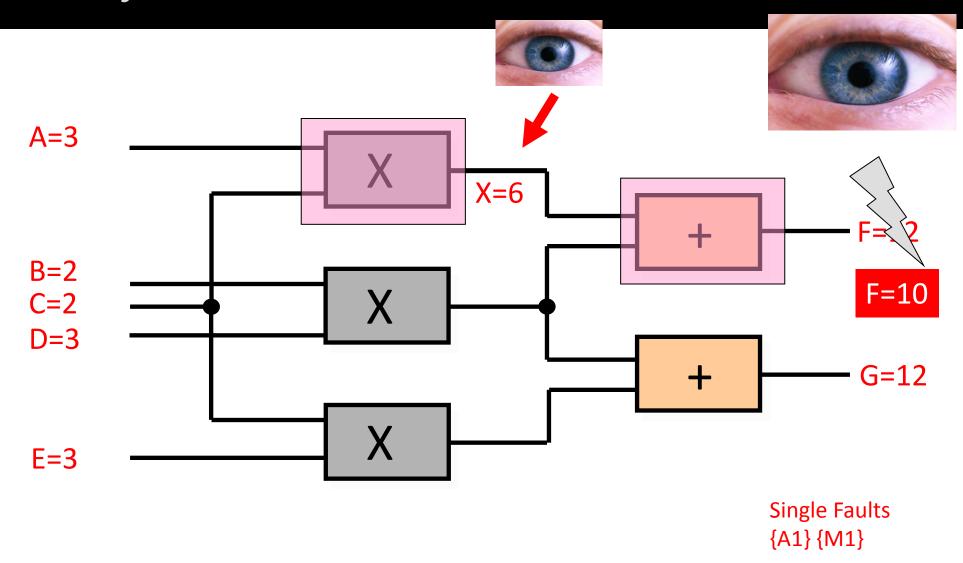
Failure Modes



Identify Other Measurements



Identify Other Measurements



The NASA ADAPT System





ADAPT (Advanced Diagnostics and Prognostics testbed) consists of a controlled and monitored environment where faults are injected into the system in a controlled manner and the performance of the test article is carefully monitored. The hardware of the testbed is an electrical power system (EPS) of a space exploration vehicle.

The DX Competition

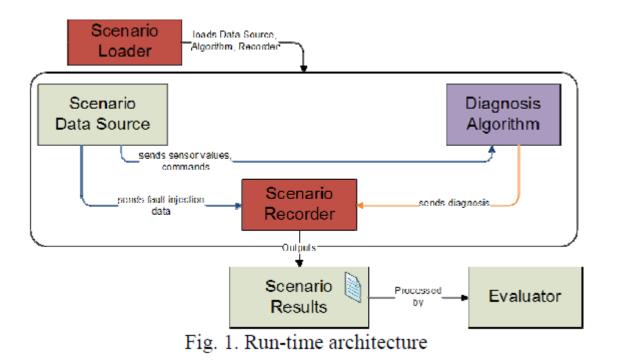
Track	Tier	Systems	Description
	1	ADAPT-	Basic faults injected into a
		Lite	simplified EPS (Electrical
			Power System) testbed
Industrial	2	ADAPT	More complex faults
	2	ADALL	injected into the full EPS
			distribution system
Synthetic	1	ISCAS85	Multiple faults injected into
			the circuits from the
			ISCAS85 benchmarks

Team Name	Track(s)	Algorithm Type
FACT	I1	Model-based
Fault Buster	I1, I2	Statistical
HyDE-A	I1, I2	Model-based
HyDE-S	I1	Model-based
Lydia	S	Model-based
NGDE	S	Model-based
ProADAPT	I1, I2	Probabilistic
RacerX	I1	Change detection
RODON	I1, I2, S	Model-based
RulesRule	I1	Rule-based
StanfordDA	I2	Optimization
Wizards of Oz	I1, I2	Model-based

Aspect	Tier 1	Tier 2
#Comps/Modes	37 / 93	173 / 430
Initial State	Relays closed; circuit breakers closed	Relays open; circuit breakers closed
Nominal mode changes?	No	Yes

			origina1			reduced
sys	IN	OUT	COMPS	V	С	COMPS
74182	9	5	19	47	75	6
74L85	11	3	33	77	118	15
74283	9	5	36	81	122	14
74181	14	8	65	144	228	15
c432	36	7	160	356	1028	59
c499	41	32	202	445	1428	58
c880	60	26	383	826	2224	77
c1355	41	32	546	1133	3220	58
c1908	33	25	880	1793	4756	160
c2670	233	140	1193	2695	6538	167
c3540	50	22	1669	3388	9216	353
c5315	178	123	2307	4792	13386	385
c2688	32	32	2416	4684	14432	1456
c7552	207	108	3512	7232	19312	545

Run-Time Architecture



Team Name	Track(s)	Algorithm Type
FACT	I1	Model-based
Fault Buster	I1, I2	Statistical
HyDE-A	I1, I2	Model-based
HyDE-S	I1	Model-based
Lydia	S	Model-based
NGDE	S	Model-based
ProADAPT	I1, I2	Probabilistic
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RODON	I1, I2, S	Model-based
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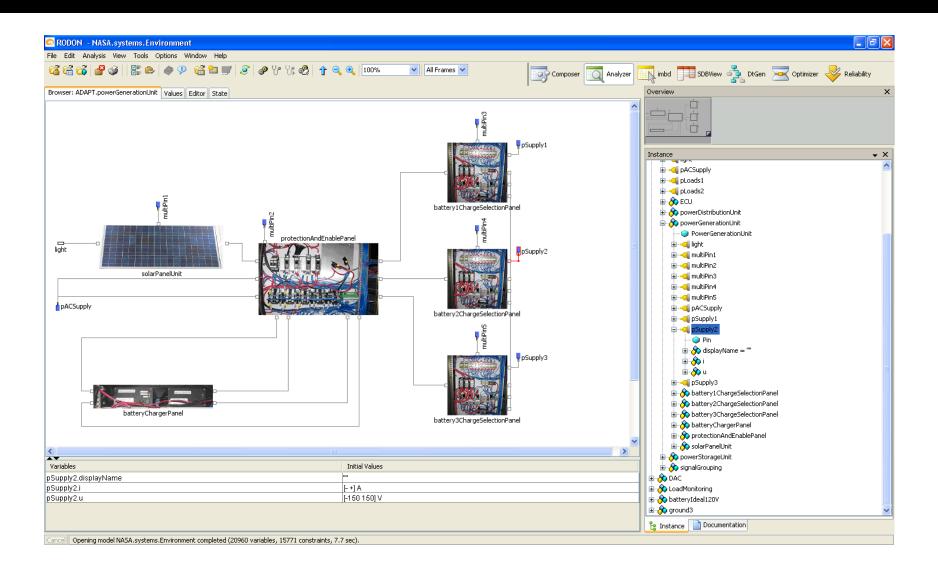
Kurtoglu T., S. Narasimhan, D. Garcia S. Poll, L. Kuhn, J. de Kleer, A. van Gemund, and A. Feldman. (2009b). "Towards a Framework for Evaluating and Comparing Diagnosis Algorithms." In Proceedings of the 20th International Workshop on Principles of Diagnosis (DX-09). (Stockholm, Sweden, June, 2009b).

Metrics

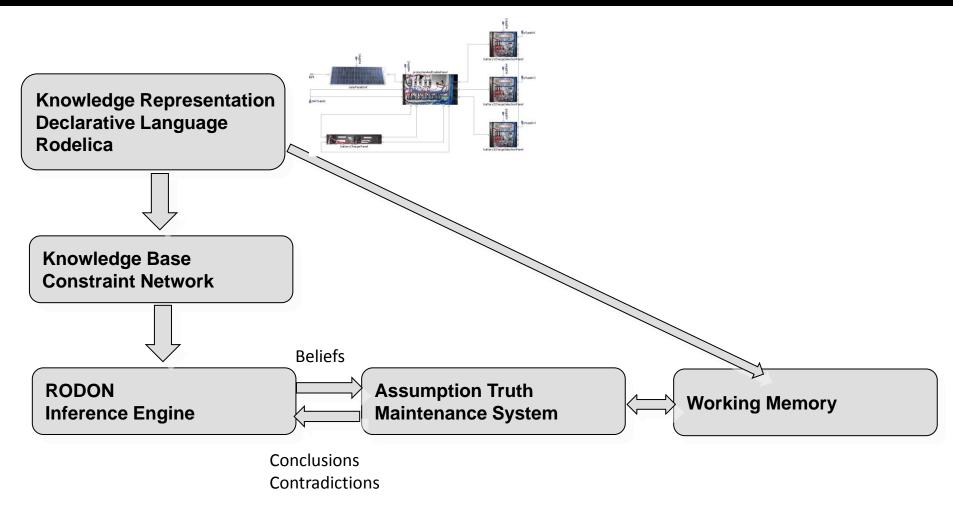
Symbol	Name	Description	Class/Category/ Tracks Used
"Per Sys	tem Description	" Metrics	
M _{FPR}	False Positives Rate	Spurious faults rate	Technical / Detection/I
M _{FNR}	False Negatives Rate	Missed faults rate	Technical / Detection/I
M _{FDA}	Detection Accuracy	Correctness of the detection	Technical / Detection/I

"Per Sce	nario" Metrics		
$ m M_{fd}$	Fault Detection Time	Time for detecting a fault	Temporal / Detection/I,S
M _{fi}	Fault Isolation Time	Time for last persistent diagnosis	Temporal / Isolation/I,S
M _{ia}	Classification Errors	Number of mode classification errors	Technical / Isolation/I
M _{utl}	Diagnostic Utility	Cost related to component replacements due to incorrect diagnosis	Technical / Isolation/S
M _{cpu}	CPU Load	CPU time spent	Computational / Detection & Isolation/I,S
M _{mem}	Memory Load	Memory allocated	Computational / Detection & Isolation/I,S

Model of the NASA ADAPT Satellite System



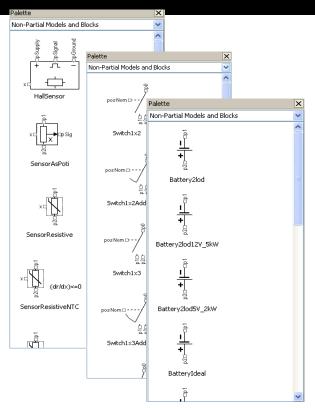
General RODON Achitecture

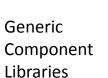


GDE [de Kleer and Williams 1987] G+DE [Heller and Struss. 2001]

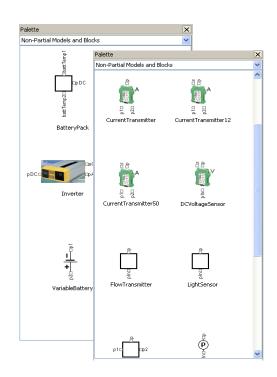
[de Kleer 1986]

The Model Building Process

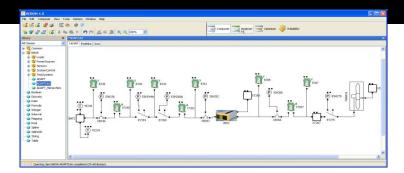


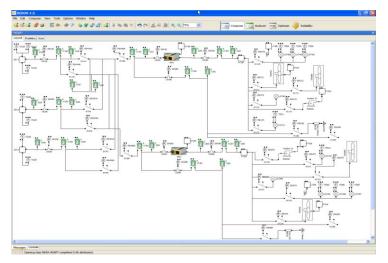


Generic



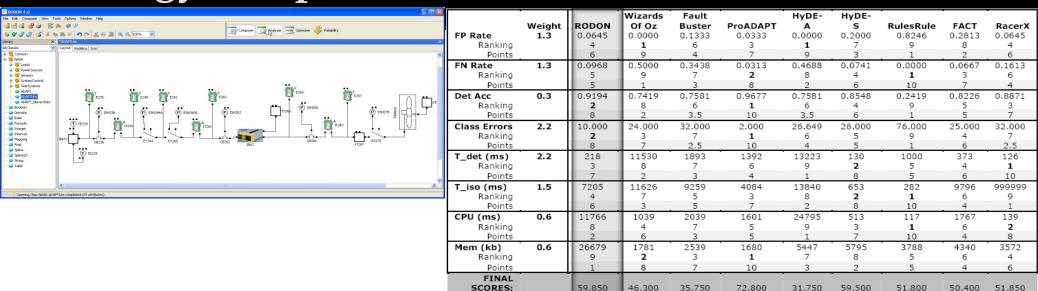
ADAPT Specific Component Libraries (derived from generic components)





ADAPT Tier1 and Tier2 assembled from model library components

Strategy Adopted for ADAPT Tier1



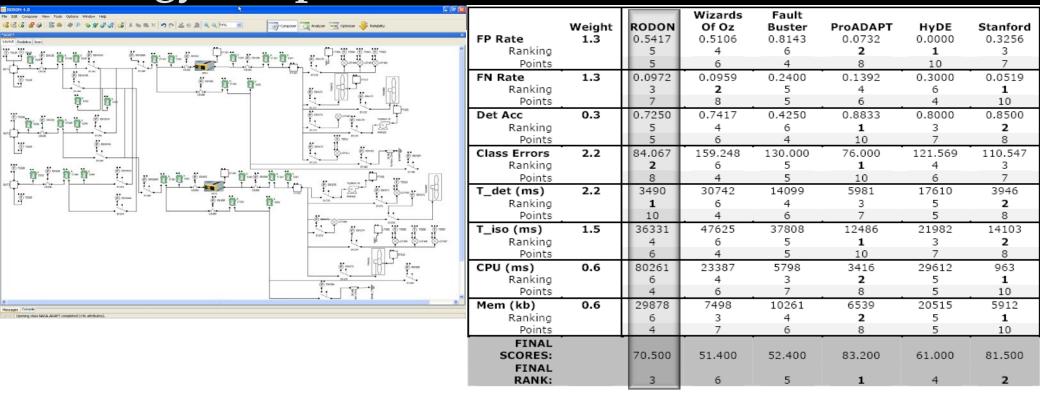
Memory and CPU are very high for RODON (we knew that we are will loose those points)

FINAL RANK:

■ The strategy was to score high on the **Detection Acuracy, Class Errors and T_Det**

Kurtoglu T., S. Narasimhan, S. Poll, D. Garcia, L. Kuhn, J. de Kleer, A. van Gemund, and A. Feldman. (2009a). "First International Diagnosis Competition – DXC'09." In Proceedings of the 20th International Workshop on Principles of Diagnosis (DX-09). (Stockholm, Sweden, June, 2009a).

Strategy Adopted for ADAPT Tier2



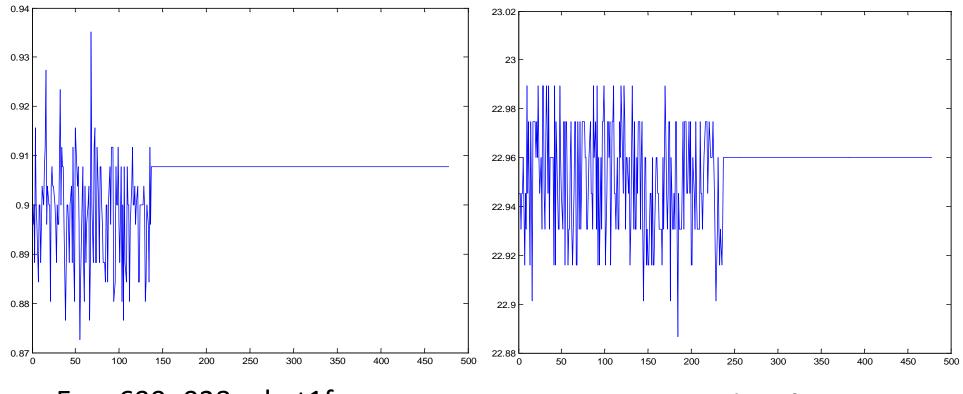
- The strategy was again to score high on the **Det_acc**, **Class_Err** and **T_dec**.
- The diagnosis engine was ignoring the transients during the switching.
- We have not noticed that the training data contained one triple fault scenario. The DA was configured to stop at double faults.
- Recomputing the scenarios by taking into account triple faults would have not changed the final clasification

Strategy Adopted for the Synthetic Track

			Lydia			NGDE			RODON				
circuit	#comp	cpu	mem	utl	cpu	mem	utl	cpu	mem	utl	Circuit	utl	nutl
74182	19	51	154	0.4137	6335	11540	0.4793	3043	19773	0.4448	74182	0,448	; (
74L85	33	68	223	0.2433	6365	11784	0.3098	3888	20979	0.1952	74L85	0,1952	
74283	36	60	229	0.1580	6385	12231	0.1553	5351	20637	0.1147	74283	0,1147	
74181	65	64	401	0.1504	6619	14625	0.1931	12527	25432	0.1417		·	
c432	160	115	878	0.0871	7520	17868	0.2096	22621	36811	0.0906	74181	0,1417	
c499	202	130	1094	0.0622	20347	32649	0.0699	23504	39872	0.0089	c432	0,0906	
c880	383	203	1945	0.0483	13718	28622	0.0401	20347	43687	0.0182	c499	0,0089	(
c1355	546	296	2759	0.0295	22550	37930	0.0246	23253	33530	0.0012	c880	0,0182	. (
c1908	880	538	4134	0.0179	26171	39843	0.0150	27718	38557	0.0180	c1355	0,0012	. (
c2670	1193	937	5867	0.0647	20537	61722	0.1076	35680	43063	0.0442	c1908	0,018	
c3540	1669	1674	7900	0.0319	27022	82045	0.0407	0	0	0.0000	c2670	0,0442	
c5315	2307	3091	11316	0.0165	30926	93116	0.0275	0	0	0.0000		·	
c6288	2416	3530	12037	0.0008	17483	102420	0.0563	0	0	0.0000	c3540	C	
c7552	3512	11817	16679	0.0317	37989	125910	0.0283	0	0	0.0000	c5315	C	(
	Averaged	1613	4687	0.0969	17855	48022	0.1255	12709	23024	0.0770	c6288	C	(
Per Me	tric Rank	1	1	2	3	3	1	2	2	3	c7552	C	(
	Points	10	10	8	7	7	10	8	8	7			
	ic Weight	1.5	1.5	7	1.5	1.5	7	1.5	1.5	7		0,077193	0,0
	nal Scores		86			91			73			0,077193	0,0
Fi	inal Rank		2			1			3				

- Compute as many candidates as possible in the given time until timeout
- c3540, c5315, c6288, c7552 were not loaded during the competion. RODON needs 35 sec to load c7552 on a 2GHz computer
- Recomputing the scenarios with a bigger start up time would have not changed the final clasification
- The training data training had scenarios with up to 5 simulateneous faults. The competition data had scenarios with up to 26 simultaneous faults.

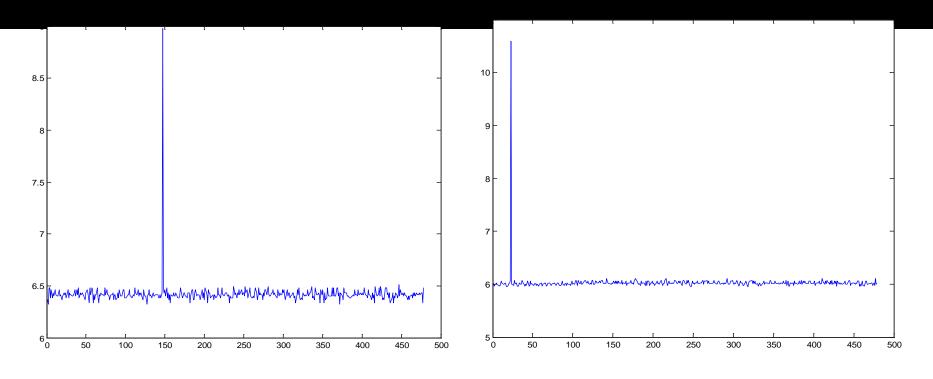
ADAPT – Tier Difficulties



- Exp_699_028_pb_t1f
 - IT267 Stuck not easily detected

- Exp_699_063_pb_t1f
 - E261Stuck not easily detected

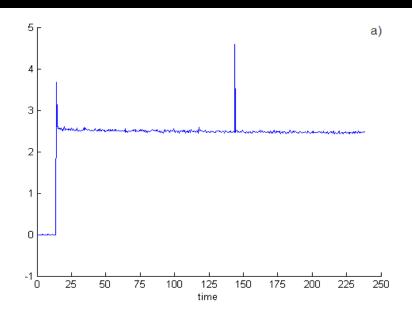
ADAPT – Tier Difficulties

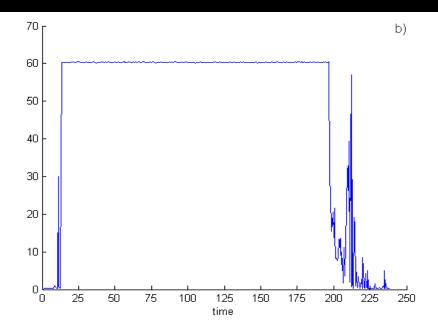


- Exp_699_071_pb_t1
 - Peak at the IT261

- Exp_725_pb_t1
 - Peak at the IT240

ADAPT – Tier Difficulties





- Exp_616_pb_t2
 - A noise in the current sensor IT 167 determined the DA to report a double fault.

- Exp_620_pb_t2
 - A noise in ST165 determined the DA to report a double fault

Conclusions

- Lack of system knowledge and interaction with the system engineers was a serious disadvantage for our team.
- We welcome the idea of the DX Competition and we are looking forward to more challenging problems.
- We would like to thank the DX Competition Challenge organizers to setting up the competition framework, providing a framework and making this possible and NASA Ames for the valuable feedback during this project.